

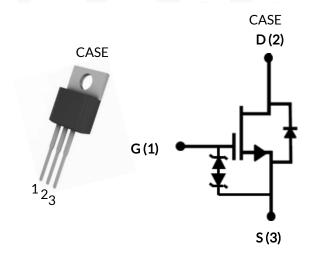


$650V\text{-}80m\Omega\,\text{SiC}\,\text{Cascode}$

Rev. A, June 2019

DATASHEET

UF3C065080T3S



Part Number	Package	Marking
UF3C065080T3S	TO-220-3L	UF3C065080T3S



Description

United Silicon Carbide's cascode products co-package its highperformance G3 SiC JFETs with a cascode optimized MOSFET to produce the only standard gate drive SiC device in the market today. This series exhibits ultra-low gate charge, but also the best reverse recovery characteristics of any device of similar ratings. These devices are excellent for switching inductive loads when used with recommended RC-snubbers, and any application requiring standard gate drive.

Features

- Typical on-resistance R_{DS(on),typ} of 80mΩ
- Maximum operating temperature of 175°C
- Excellent reverse recovery
- Low gate charge
- Low intrinsic capacitance
- ESD protected, HBM class 2
- Very low switching losses (required RC-snubber loss negligible under typical operating conditions)

Typical applications

- EV charging
- PV inverters
- Switch mode power supplies
- Power factor correction modules
- Motor drives
- Induction heating





Maximum Ratings

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	V _{DS}		650	V
Gate-source voltage	V _{GS}	DC	-25 to +25	V
Continuous drain current ¹		T _C = 25°C	31	А
Continuous drain current	ID	T _C = 100°C	23	А
Pulsed drain current ²	I _{DM}	T _C = 25°C	65	А
Single pulsed avalanche energy ³	E _{AS}	L=15mH, I _{AS} =2.1A	33	mJ
Power dissipation	P _{tot}	T _C = 25°C	190	W
Maximum junction temperature	T _{J,max}		175	°C
Operating and storage temperature	T _J , T _{STG}		-55 to 175	°C
Max. lead temperature for soldering, 1/8" from case for 5 seconds	TL		250	°C

1. Limited by $T_{\mbox{\tiny J,max}}$

2. Pulse width t_p limited by $T_{J,max}$

3. Starting $T_J = 25^{\circ}C$

Thermal Characteristics

Parameter	Symbol	Test Conditions	Value			Units
			Min	Тур	Max	Units
Thermal resistance, junction-to-case	$R_{\theta JC}$			0.61	0.79	°C/W









Electrical Characteristics (T_J = +25°C unless otherwise specified)

Typical Performance - Static

Parameter	Symbol	Test Conditions	Value			Linte	
Parameter			Min	Тур	Max	Units	
Drain-source breakdown voltage	BV _{DS}	V _{GS} =0V, I _D =1mA	650			V	
Total drain leakage current	I _{DSS}	V _{DS} =650V, V _{GS} =0V, T _J =25°C		6	100		
		V _{DS} =650V, V _{GS} =0V, T _J =175°C		40		μΑ	
Total gate leakage current	I _{GSS}	V _{DS} =0V, T _J =25°C, V _{GS} =-20V / +20V		6	±20	μA	
Drain-source on-resistance	R _{DS(on)}	V _{GS} =12V, I _D =20A, T _J =25°C		80	100	mΩ	
		V _{GS} =12V, I _D =20A, T _J =175°C		141			
Gate threshold voltage	V _{G(th)}	V_{DS} =5V, I_{D} =10mA	4	5	6	V	
Gate resistance	R _G	f=1MHz, open drain		4.5		Ω	

Typical Performance - Reverse Diode

Parameter	Symbol	Test Conditions	Value			
			Min	Тур	Max	- Units
Diode continuous forward current ¹	I _S	T _C =25°C			31	А
Diode pulse current ²	I _{S,pulse}	T _C =25°C			65	А
Forward voltage	V _{FSD}	V _{GS} =0V, I _F =10A, T _J =25°C		1.5	2	V
		V _{GS} =0V, I _F =10A, T _J =175°C		1.75		
Reverse recovery charge	Q _{rr}	V _R =400V, I _F =20A, V _{GS} =-5V, R _{G_EXT} =10Ω		119		nC
Reverse recovery time	t _{rr}	di/dt=2200A/µs, T_=25°C		16		ns
Reverse recovery charge	Q _{rr}	V_{R} =400V, I _F =20A, V_{GS} =-5V, $R_{G_{EXT}}$ =10 Ω		73		nC
Reverse recovery time	t _{rr}	di/dt=2200A/µs, Tj=150°C		11		ns







Typical Performance - Dynamic

Parameter	Symbol	Test Conditions	Value			Units
			Min	Тур	Max	Units
Input capacitance	C _{iss}	- V _{DS} =100V, V _{GS} =0V -		1500		
Output capacitance	C _{oss}	- f=100kHz -		104		pF
Reverse transfer capacitance	C _{rss}			2.6		
Effective output capacitance, energy related	C _{oss(er)}	$V_{DS}=0V$ to 400V, $V_{GS}=0V$		77		pF
Effective output capacitance, time related	C _{oss(tr)}	$V_{DS}=0V$ to 400V, $V_{GS}=0V$		176		pF
C _{OSS} stored energy	E _{oss}	V _{DS} =400V, V _{GS} =0V		6.2		μJ
Total gate charge	Q _G	– V _{DS} =400V, I _D =20A, –		51		
Gate-drain charge	Q _{GD}	$V_{DS} = -5V \text{ to } 15V$		11		nC
Gate-source charge	Q _{GS}	VGS - 5V (015V		19		
Turn-on delay time	t _{d(on)}			25		- ns
Rise time	t _r	V_{DS} =400V, I_D =20A, Gate		14		
Turn-off delay time	t _{d(off)}	Driver =-5V to +15V, Turn-on $R_{G,EXT}$ =1 Ω ,		54		
Fall time	t _f	Turn-off $R_{G,EXT}$ =22 Ω		11		
Turn-on energy including R _s energy ⁴	E _{ON}	Inductive Load,		182		μ
Turn-off energy including R _s energy ⁴	E _{OFF}	FWD: same device with $-V_{GS} = -5V$ and $R_G = 22\Omega$, $-$		24		
Total switching energy including R_s energy ⁴	E _{TOTAL}	RC snubber: $R_s = 5\Omega$ and $C_s = 22\Omega$, $C_s = 100pF$,		206		
Snubber R _s energy during turn-on	E _{RS_ON}	$T_1=25^{\circ}C$		0.6		
Snubber R _s energy during turn-off	E _{RS_OFF}			1.1		
Turn-on delay time	t _{d(on)}			22		- ns
Rise time	t _r	V_{DS} =400V, I_D =20A, Gate		14		
Turn-off delay time	t _{d(off)}	Driver =-5V to +15V, Turn-on $R_{G,EXT}=1\Omega$, Turn-off $R_{G,EXT}=22\Omega$		55		
Fall time	t _f			12		
Turn-on energy including R _s energy ⁴	E _{ON}	Inductive Load, FWD: same device with $V_{GS} = -5V$ and $R_G = 22\Omega$, RC snubber: $R_S=5\Omega$ and $C_S=100pF$, $T_J=150^{\circ}C$		156		_
Turn-off energy including R _s energy ⁴	E _{OFF}			25		
Total switching energy including R_S energy ⁴	E _{TOTAL}			181		μJ
Snubber $R_{\rm S}$ energy during turn-on	E _{RS_ON}			0.6		_
Snubber R _s energy during turn-off	E _{RS_OFF}			1.2		

4. The switching performance are evaluated with a RC snubber circuit as shown in Figure 24.





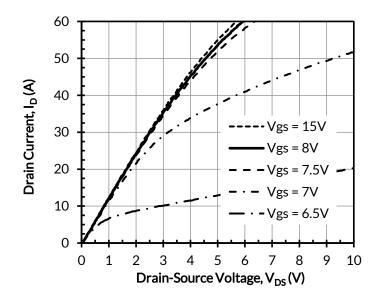
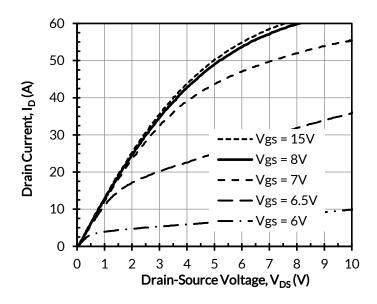


Figure 1. Typical output characteristics at T $_{\rm J}$ = - 55°C, $t_{\rm p}$ < 250 μs



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Figure 2. Typical output characteristics at T_J = 25°C, $t_p < 250 \mu s$

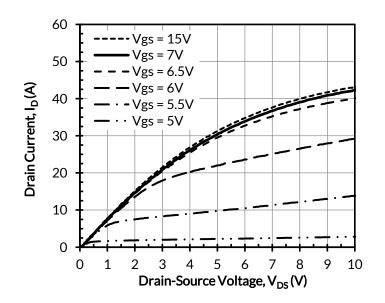


Figure 3. Typical output characteristics at T $_{\rm J}$ = 175°C, t_p < 250 μs

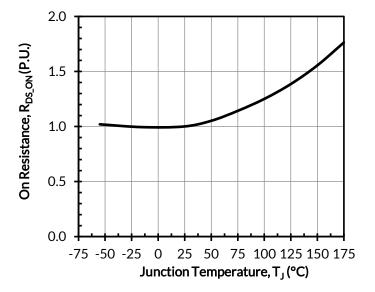


Figure 4. Normalized on-resistance vs. temperature at V_{GS} = 12V and I_D = 20A



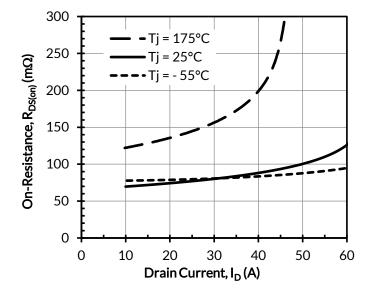
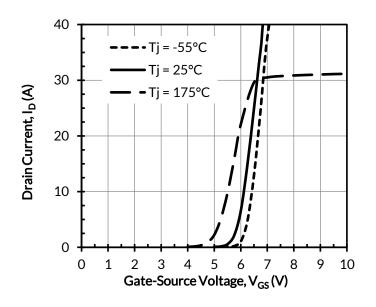


Figure 5. Typical drain-source on-resistances at V_{GS} = 12V



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Figure 6. Typical transfer characteristics at V_{DS} = 5V

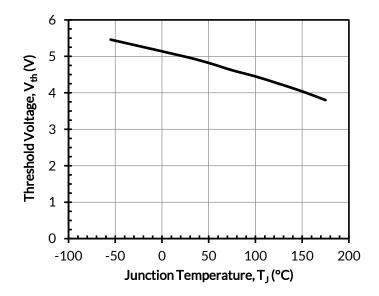


Figure 7. Threshold voltage vs. junction temperature at V_{DS} = 5V and I_{D} = 10mA

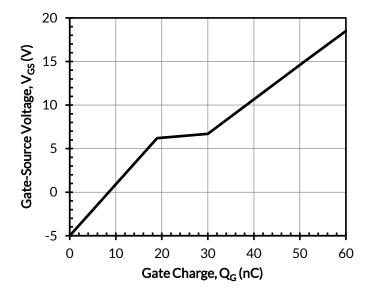


Figure 8. Typical gate charge at V_{DS} = 400V and I_{D} = 20A





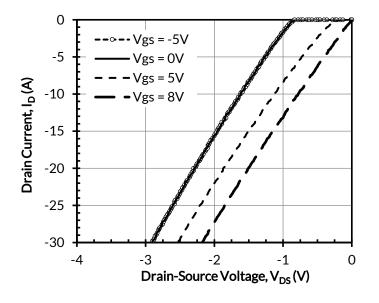


Figure 9. 3rd quadrant characteristics at $T_J = -55^{\circ}C$

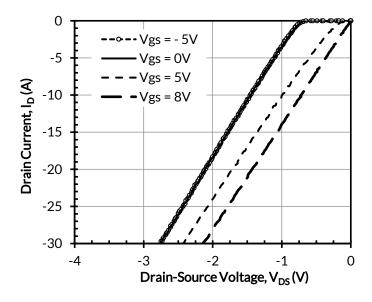


Figure 10. 3rd quadrant characteristics at T_J = 25°C

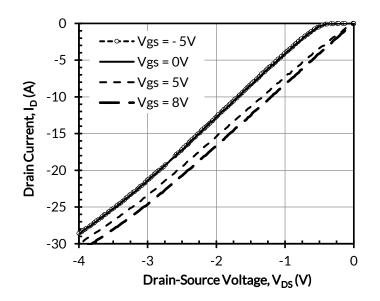


Figure 11. 3rd quadrant characteristics at T_J = 175°C

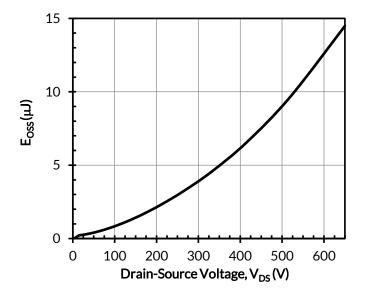


Figure 12. Typical stored energy in C_{OSS} at V_{GS} = 0V



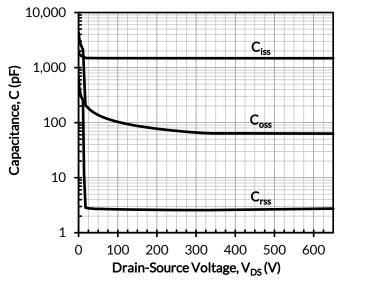
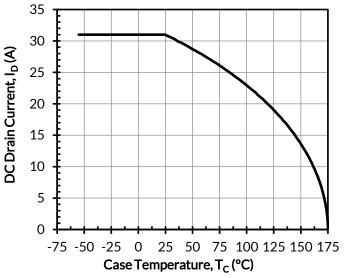


Figure 13. Typical capacitances at f = 100kHz and V_{GS} = 0V



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Figure 14. DC drain current derating

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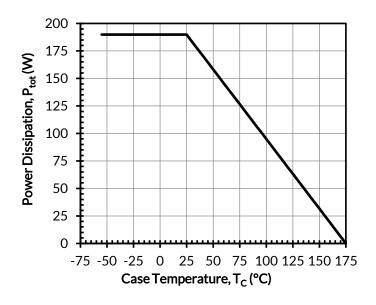


Figure 15. Total power dissipation

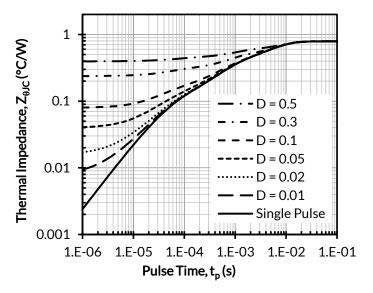


Figure 16. Maximum transient thermal impedance





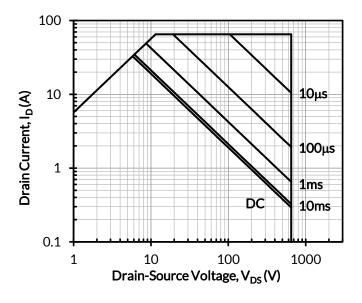


Figure 17. Safe operation area at $T_{\rm C}$ = 25°C, D = 0, Parameter $t_{\rm p}$

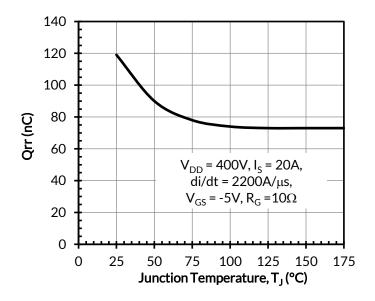
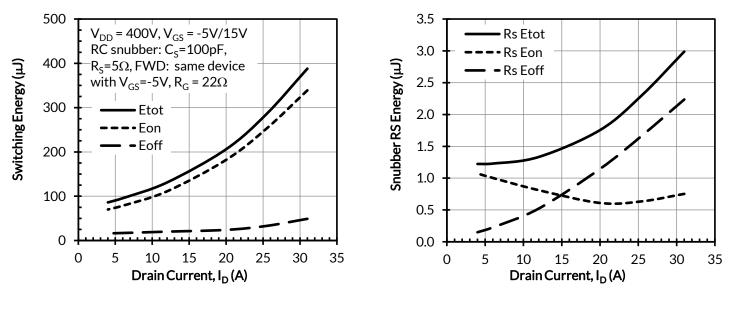


Figure 18. Reverse recovery charge Qrr vs. junction temperture

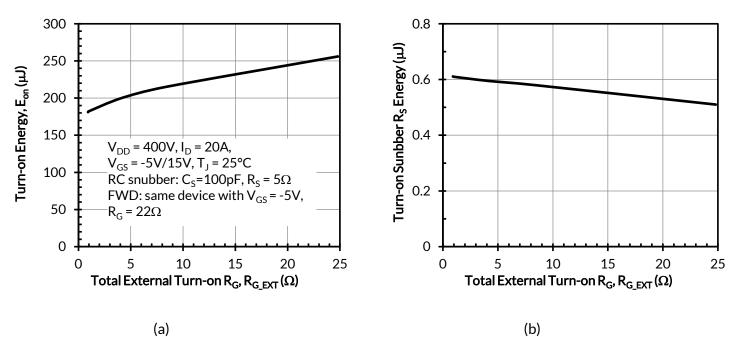


(a)

(b)

Figure 19. Clamped inductive switching energy (a) and RC snubber energy loss (b) vs. drain current at $T_J = 25^{\circ}$ C, turn-on $R_{G,EXT} = 1\Omega$, and turn-off $R_{G,EXT} = 22\Omega$





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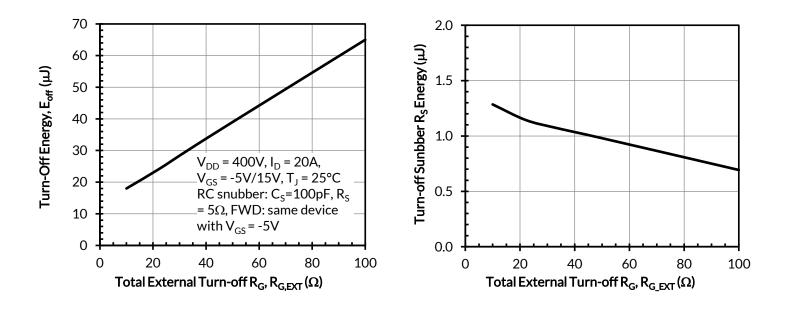
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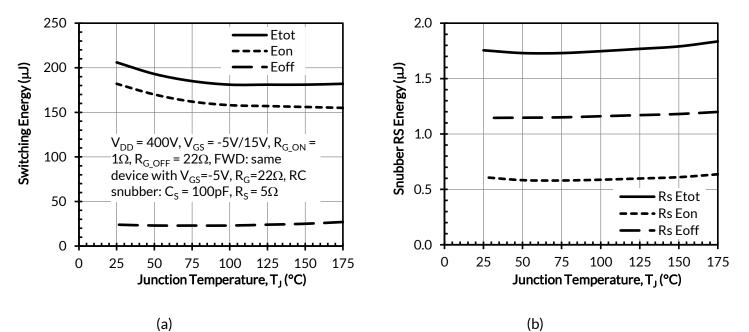
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Figure 20. Clamped inductive switching turn-on energy including RC snubber energy loss (a) and RC snubber energy loss (b) as a function of total external turn-on gate resistor $R_{G,EXT}$



(a) (b) Figure 21. Clamped inductive switching turn-off energy including RC snubber energy loss (a) and RC snubber energy loss (b) as a function of total external turn-off gate resistor $R_{G EXT}$





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Figure 22. Clamped inductive switching energy including RC snubber energy loss (a) and RC snubber energy loss (b) as a function of junction temperature at $I_D = 20A$

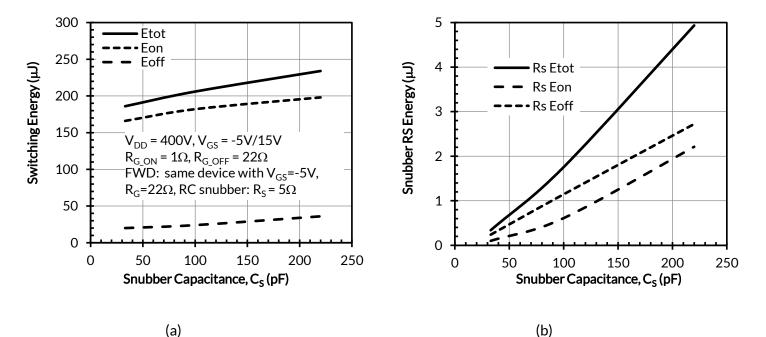


Figure 23. Clamped inductive switching energy including RC snubber energy loss (a) and RC snubber energy loss (b) as a function of snubber capacitance at $I_D = 20A$ and $T_J = 25^{\circ}C$







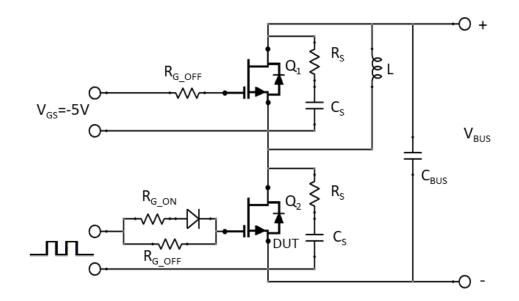


Figure 24. Clamped inductive load switching test circuit An RC snubber ($R_s = 5\Omega$ and $C_s = 100$ pF) is required to improve the turn-off waveforms.

Applications Information

SiC cascodes are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ($R_{DS(on)}$), output capacitance (C_{oss}), gate charge (Q_G), and reverse recovery charge (Qrr) leading to low conduction and switching losses. The SiC cascodes also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the cascode is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on cascode operation, see www.unitedsic.com.

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